

08-18-2003

**INFORMATION DISCLOSURE CITATION**  
*(Use several sheets if necessary)*

Docket Number (Optional)

CHAOS1220

Application Number

Unknown

Applicant(s)

P.H. Bryant

Filing Date

-Herewith

Group Art Unit

Unknown

2614

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Bkt.		6,272,209	04/22/19970	Bridger et al	379	27	08/16/1999
Bkt.		6,275,050	08/14/2001	Born et al	324	700	11/29/1999
Bkt.		6,519,253	02/11/2003	Posthuma	370	359	02/25/1999

**FOREIGN PATENT DOCUMENTS**

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO

**OTHER DOCUMENTS** *(Including Author, Title, Date, Pertinent Pages, Etc.)*

Bkt.	United States Department of Agriculture Bulletin 1751H-501, Fundamentals of ISDN, Pages 1-26
	Conference Paper Proceedings of the 34th Meeting of IEEE Holm Conference on Electrical Contacts, 1988, IEEE Cat. No. 88CH2604-7, The Effects of Current on Stationary Contact Behavior, W.W. Bennett, Pages 267-276
Bkt.	Physical Review B, Volume 43, Number 2, 15 January 1991-I, Degradation and Regeneration of Copper Electrical Junctions, Pages 1433-1440
	Conference Paper INTELEC, Tenth Int'l Telecommunications Energy Conference, 1988, IEEE Cat. No. 88CH2653-4, Sealing Current and Its Impact on ISDN Powering Requirements, Frantz and Taylor, Pages 151-155.

EXAMINER

B. H. F. Fied

DATE CONSIDERED

DEC. 14, 2007.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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*EXAMINER INITIAL	OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>				
BKT	Splice-induced Impairments on Very-High-Speed Digital Data Communications Over Coper Telephone Networks, K. Sistanizadeh, Pages 3-15, UCLA Science & Engineering Library  Analysis of the Noice Environment in Fugure Twisted-Pair Access Technologies, Magesacher, Haar, and Zukunft, Institute for Integrated Circuits - Bridgelab, Munich, Germany, paages 1-5				
BK <sub>1</sub>	Standard for ISDN-Basic Access Interface for Application on the Network Side of the NT, Layer 1 Specification, Sealing Current Provisioning, S.G. Ungar, TIE1.4 Technical Subcommittee Working Group Members, pages 1-26.				
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Binh k. Tieu		Dec. 14, 2007.			
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